



FORM PTO-1449/A and B (Modified)  INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICATION NO.: 09/361,700		ATTY. DOCKET NO.: S01022.80201.US
	FILING DATE: July 27, 1999		CONFIRMATION NO.: 5850
	APPLICANT: Pierrick Descure		
	GROUP ART UNIT: 2811		EXAMINER: Gene M. Munson.
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## U.S. PATENT DOCUMENTS

Examiner's Initials	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication or of issue of Cited Document MM-DD-YYYY
		Number	Kind Code		
27K26		4,630,091		Kuroda et al.	12-16-1986
		5,191,399		Maegawa et al.	03-02-1993
		5,306,931		Stevens	04-26-1994
		5,330,933		Chan et al.	07-19-1994
		5,345,266		Denyer	09-06-1994
		5,591,997		Guidash et al.	01-07-1997
		5,621,230		Guidash et al.	04-15-1997
		5,747,835		Pezzani	05-05-1998
		5,831,326		Chan et al.	11-03-1998
		5,859,462		Tredwell et al.	01-12-1999
		5,881,184		Guidash	03-09-1999
		5,903,021		Lee et al.	05-11-1999
		5,926,214		Denyer et al.	07-20-1999
		5,949,061		Guidash et al.	09-07-1999
		5,978,025		Tomasini et al.	11-02-1999
		5,981,932		Guerrieri et al.	11-09-1999
		5,982,011		Kalnitsky et al.	11-09-1999
		5,986,297		Guidash et al.	11-16-1999
		6,051,447		Lee et al.	04-18-2000
		6,067,113		Hurwitz et al.	05-23-2000
		6,069,377		Prentice et al.	05-30-2000
		6,087,703		Ohta et al.	07-11-2000
		6,100,551		Lee et al.	08-08-2000
		6,100,556		Drowley et al.	08-08-2000
		6,107,655		Guidash	08-22-2000
		6,127,697		Guidash	10-03-2000
		6,133,954		Jie et al.	10-17-2000
		6,160,281		Guidash	12-12-2000
		6,188,056	B1	Kalnitsky et al.	02-13-2001
		6,218,656	B1	Guidash	04-17-2001
		6,259,124	B1	Guidash	07-10-2001
		<del>US 2001/0045580</del>	<del>A1</del>	<del>Descure</del>	<del>11-29-2001</del>
		<del>US 2002/0011638</del>	<del>A1</del>	<del>Bordogna et al.</del>	<del>01-31-2002</del> 03-25-2003
		US 2002/0019070	A1	Laurin et al.	02-14-2002
		6,352,876	B1	Bordogna et al.	03-05-2002
		<del>US 2002/0030753</del>	<del>A1</del>	<del>Kramer et al.</del>	<del>03-14-2002</del> 01-07-2003
		<del>6,380,572</del>	<del>B1</del>	<del>Pain et al.</del>	<del>04-30-2002</del>

this application

filed after  
07/27/1999

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<del>6,677,656</del>	B2	François	01/13/2004
<del>6,781,169</del>	B2	Roy	08/24/2004
<del>2002/0166951</del>	A1	Cazaux	11/14/2002
<del>2002/0051067</del>	A1	Henderson et al.	05-03-2002

filed after  
07/27/1999

#### FOREIGN PATENT DOCUMENTS

Examiner's Initials	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited Document (not necessary)	Date of Publication of Cited Document MM-DD-YYYY	Translation (Y/N)
		Office/Country	Number	Kind Code			
9/27/99		EP	1 207 686	A1	STMicroelectronics Limited	05-22-2002	—
		GB	2 276 512	A	VLSI Vision Limited	09-28-1994	—
		WO	92/15036	A1	VLSI Vision Limited	09-03-1992	—
		WO	92/16999	A1	VSLI Vision Limited	10-01-1992	—
		WO	93/04556	A1	VSLI Vision Limited	03-04-1993	—
		WO	97/20434	A1	VSLI Vision Limited	06-05-1997	—
		WO	97/35438	A1	VSLI Vision Limited	09-25-1997	—
		WO	98/49729	A1	VSLI Vision Limited	11-05-1998	—
		WO	99/57887	A1	VSLI Vision Limited	11-11-1999	—
9/27/99		WO	00/52765	A1	Photobit Corporation	09-08-2000	—

#### OTHER ART — NON PATENT LITERATURE DOCUMENTS

Examiner's Initials	Cite No.	Include name of the author (in CAPITAL LETTERS) title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, relevant page(s), volume-issue number(s), publisher, city and/or country where published.	Translation (Y/N)
9/27/99		Patent Abstracts of Japan, vol. 009, no. 061, March 19, 1985 & JP 59 198756 A (Hitachi Seisakusho KK)	—
		Patent Abstracts of Japan, vol. 1998, no. 03, February 27, 1998 & JP 09 289301 A (Nikon Corp.) November 4, 1997	—
		Patent Abstracts of Japan, vol. 1998, no. 09, July 31, 1998 & JP 10 098175 A (Toshiba Corp.)	—
		Patent Abstracts of Japan, vol. 2000, no. 11, January 2, 2001 & JP 2000 236081 A (Nikon Corp.) August 29, 2000	—
9/27/99		Furumiya M. et al., "High Sensitivity and No-Cross-Talk Pixel Technology For Embedded CMOS Image Sensor" International Electron Devices Meeting 2000. IEDM. Technical Digest, San Francisco, CA, Dec. 10-13, 2000, New York, NY: IEEE, US, December 10, 2000, pages 701-704	—

EXAMINER <b>G. MUNSON</b>	DATE CONSIDERED <b>5 AUGUST 2005</b>
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#EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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